

N-Channel 25-V (D-S) MOSFET

PRODUCT SUMMARY

V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A) ^{a, d}	Q_g (Typ.)
25	0.0045 at $V_{GS} = 10$ V	50	36.25 nC
	0.0060 at $V_{GS} = 4.5$ V	50	

FEATURES

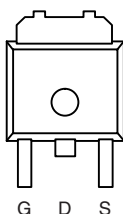
- TrenchFET[®] Power MOSFET
- 100 % R_g and UIS Tested

APPLICATIONS

- DC/DC Conversion, Low-Side
 - Desktop PC
 - Server


RoHS
COMPLIANT

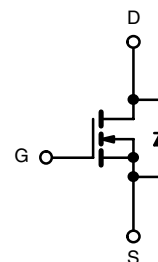
TO-252



Top View

Drain Connected to Tab

Ordering Information: SUD50N025-4m5P-E3 (Lead (Pb)-free)



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	25	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current ($T_J = 175$ °C)	$T_C = 25$ °C	I_D	50 ^{a, d}	A
	$T_C = 70$ °C		50 ^{a, d}	
	$T_A = 25$ °C		18 ^{b, c}	
	$T_A = 70$ °C		15 ^{b, c}	
Pulsed Drain Current		I_{DM}	100	
Avalanche Current		I_{AS}	28	
Repetitive Avalanche Energy		E_{AS}	39	V
Continuous Source-Drain Diode Current	$T_C = 25$ °C	I_S	50 ^{a, d}	A
	$T_A = 25$ °C		2.1 ^{b, c}	
Maximum Power Dissipation	$T_C = 25$ °C	P_D	108 ^a	W
	$T_C = 70$ °C		75.6 ^a	
	$T_A = 25$ °C		2.5 ^{b, c}	
	$T_A = 70$ °C		1.75 ^{b, c}	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	- 55 to 175	°C

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, c}	$t \leq 10$ s	R_{thJA}	48	60	°C/W
Maximum Junction-to-Case	Steady State	R_{thJC}	1.6	2	

Notes:

a. Based on $T_C = 25$ °C.

b. Surface Mounted on 1" x 1" FR4 board.

c. $t = 10$ s.

d. Calculated based on maximum junction temperature. Package limitation current is 50 A.

e. Maximum under Steady State conditions is 90 °C/W.

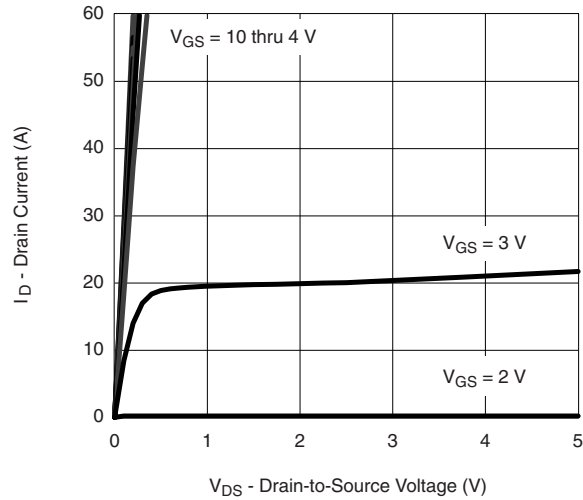
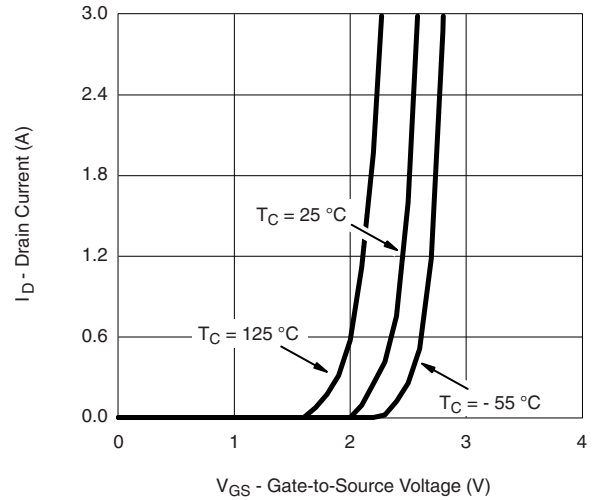
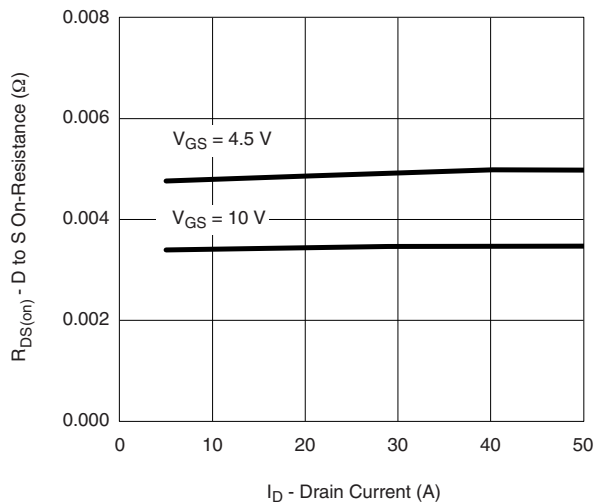
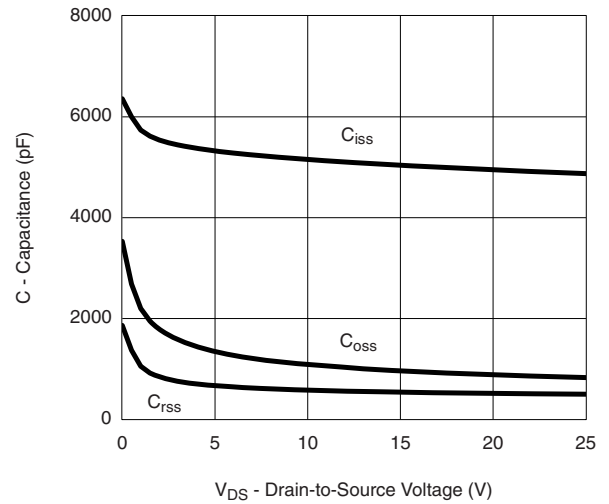
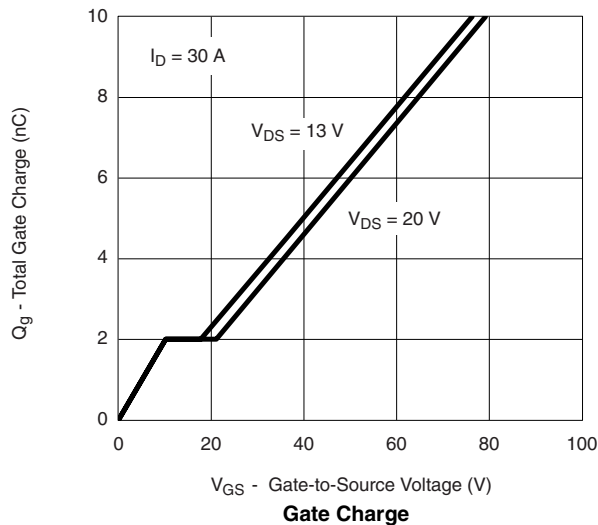
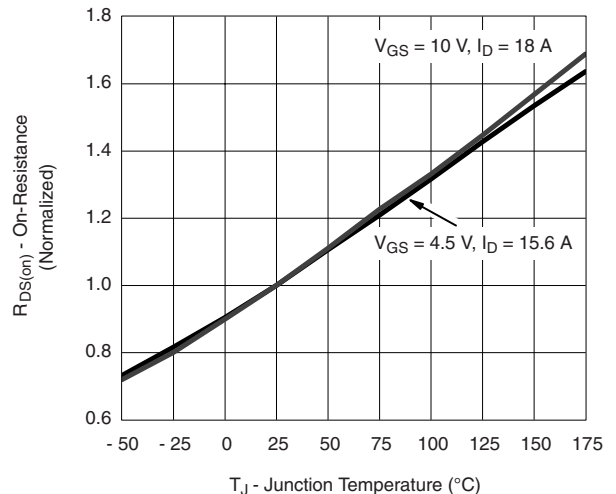
SPECIFICATIONS $T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0\text{ V}$, $I_D = 250\text{ }\mu\text{A}$	25			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$		25.7		mV/ $^{\circ}\text{C}$
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 6.6		
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$	1		3	V
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0\text{ V}$, $V_{GS} = \pm 20\text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 25\text{ V}$, $V_{GS} = 0\text{ V}$			1	μA
		$V_{DS} = 25\text{ V}$, $V_{GS} = 0\text{ V}$, $T_J = 55\text{ }^{\circ}\text{C}$			10	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} \geq 5\text{ V}$, $V_{GS} = 10\text{ V}$	50			A
Drain-Source On-State Resistance ^a	$R_{DS(on)}$	$V_{GS} = 10\text{ V}$, $I_D = 18\text{ A}$		0.0037	0.0045	Ω
		$V_{GS} = 4.5\text{ V}$, $I_D = 15\text{ A}$		0.005	0.006	
Forward Transconductance ^a	g_{fs}	$V_{DS} = 15\text{ V}$, $I_D = 18\text{ A}$		98		S
Dynamic ^b						
Input Capacitance	C_{iss}	$V_{DS} = 12\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$		5102		pF
Output Capacitance	C_{oss}			1025		
Reverse Transfer Capacitance	C_{rss}			525		
Total Gate Charge	Q_g	$V_{DS} = 13\text{ V}$, $V_{GS} = 10\text{ V}$, $I_D = 18\text{ A}$		76.3	115	nC
		$V_{DS} = 13\text{ V}$, $V_{GS} = 4.5\text{ V}$, $I_D = 15\text{ A}$		36.3	55	
Q_{gs}			10.2			
Q_{gd}			7.6			
Gate Resistance	R_g	$f = 1\text{ MHz}$	0.53	1.05	1.58	Ω
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 13\text{ V}$, $R_L = 0.722\text{ }\Omega$ $I_D \equiv 18\text{ A}$, $V_{GEN} = 4.5\text{ V}$, $R_g = 1\text{ }\Omega$		48	72	ns
Rise Time	t_r			175	263	
Turn-Off Delay Time	$t_{d(off)}$			84	126	
Fall Time	t_f			51	77	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 13\text{ V}$, $R_L = 0.87\text{ }\Omega$ $I_D \equiv 15\text{ A}$, $V_{GEN} = 10\text{ V}$, $R_g = 1\text{ }\Omega$		24	36	
Rise Time	t_r			8	12	
Turn-Off Delay Time	$t_{d(off)}$			12	18	
Fall Time	t_f			8.5	13	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C = 25\text{ }^{\circ}\text{C}$			50	A
Pulse Diode Forward Current ^a	I_{SM}				90	
Body Diode Voltage	V_{SD}	$I_S = 15\text{ A}$		0.9	1.5	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = 5\text{ A}$, $dI/dt = 100\text{ A}/\mu\text{s}$, $T_J = 25\text{ }^{\circ}\text{C}$		26.3	40	ns
Body Diode Reverse Recovery Charge	Q_{rr}			16	24	nC
Reverse Recovery Fall Time	t_a			12.8		ns
Reverse Recovery Rise Time	t_b			13.5		

Notes:

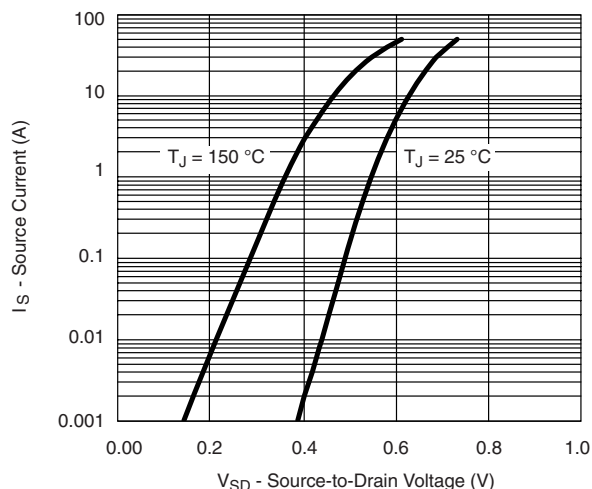
a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

b. Guaranteed by design, not subject to production testing.

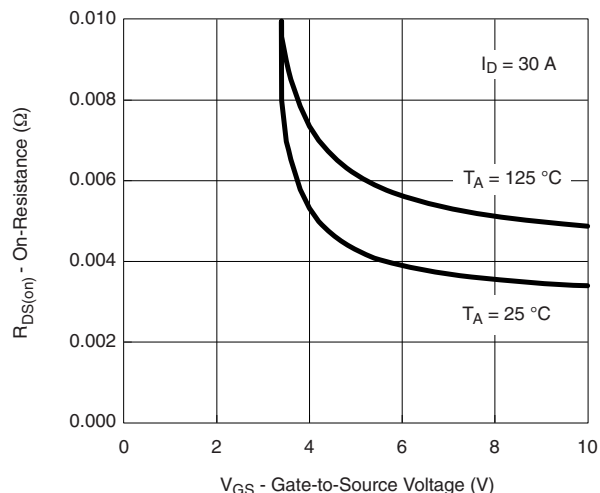
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted**Output Characteristics****Transfer Characteristics** **$r_{DS(on)}$ vs. Drain Current****Capacitance****Gate Charge****On-Resistance vs. Junction Temperature**

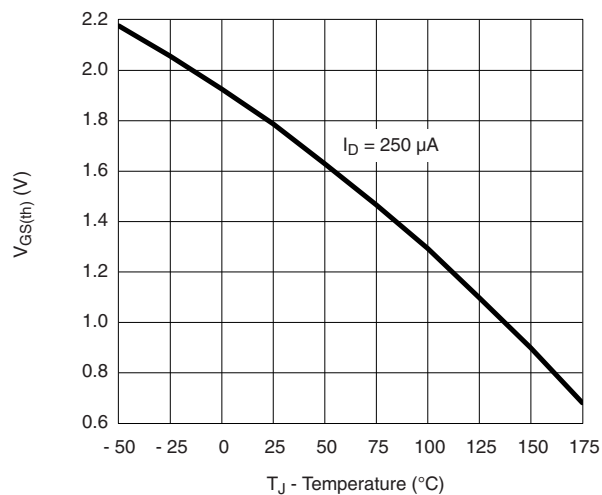
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



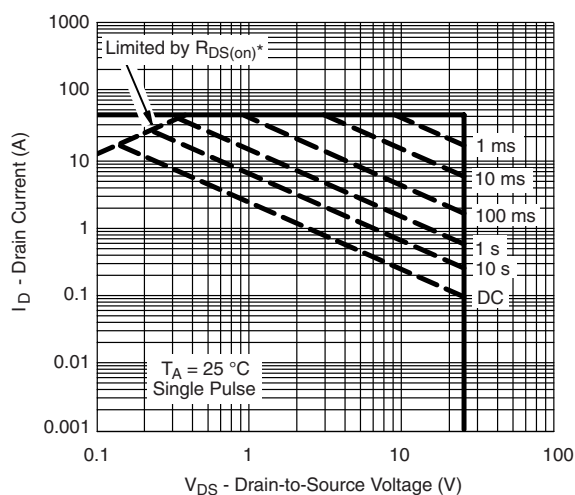
Forward Diode Voltage vs. Temperature



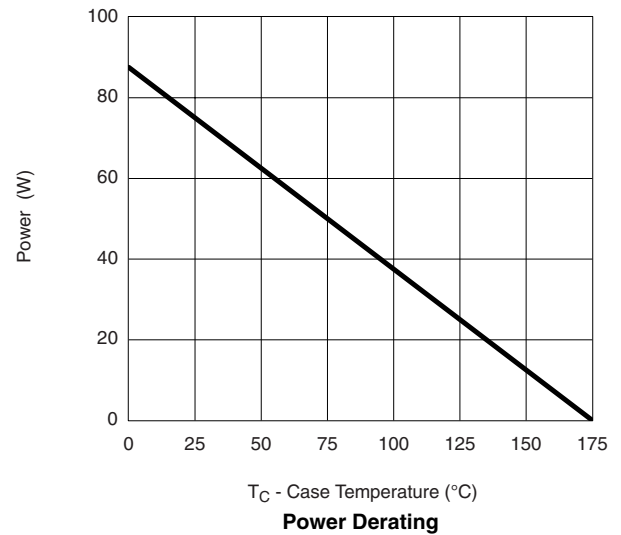
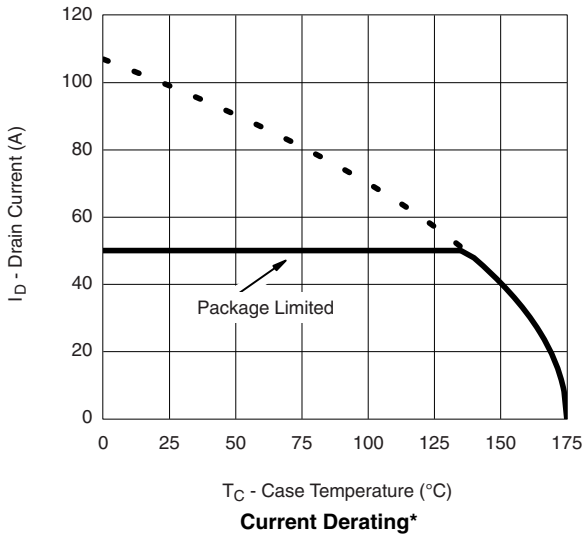
$R_{DS(on)}$ vs. V_{GS} vs. Temperature



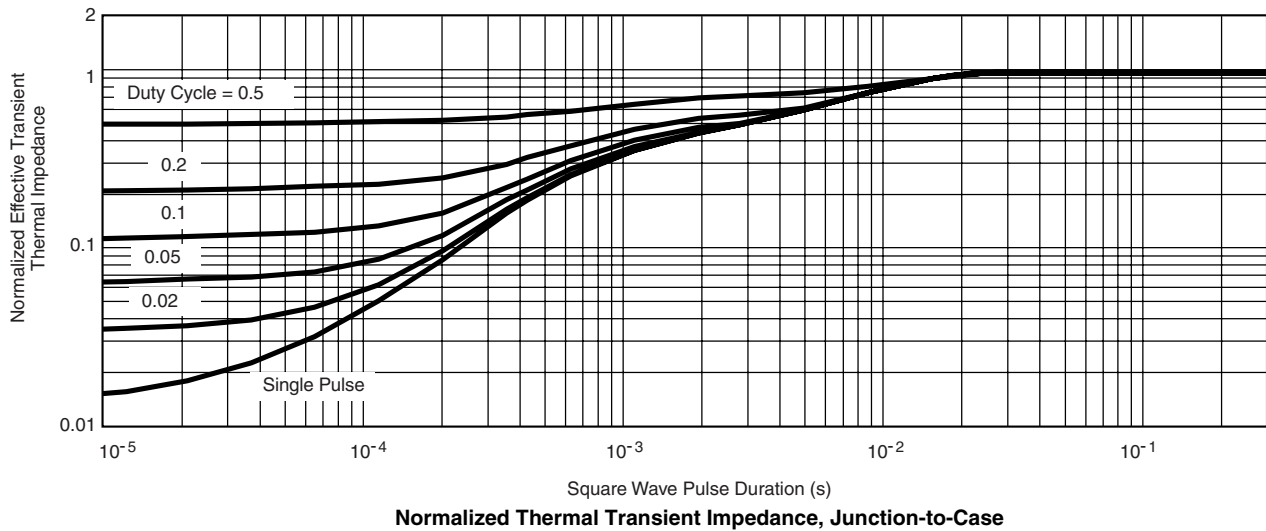
Threshold Voltage



* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified
Safe Operating Area, Junction-to-Ambient

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

* The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



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